

Interfacial Engineering of Hole Transport Layer with Metal and Dielectric Nanoparticles for Efficient Perovskite Solar Cells

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Electronic Supplementary Information

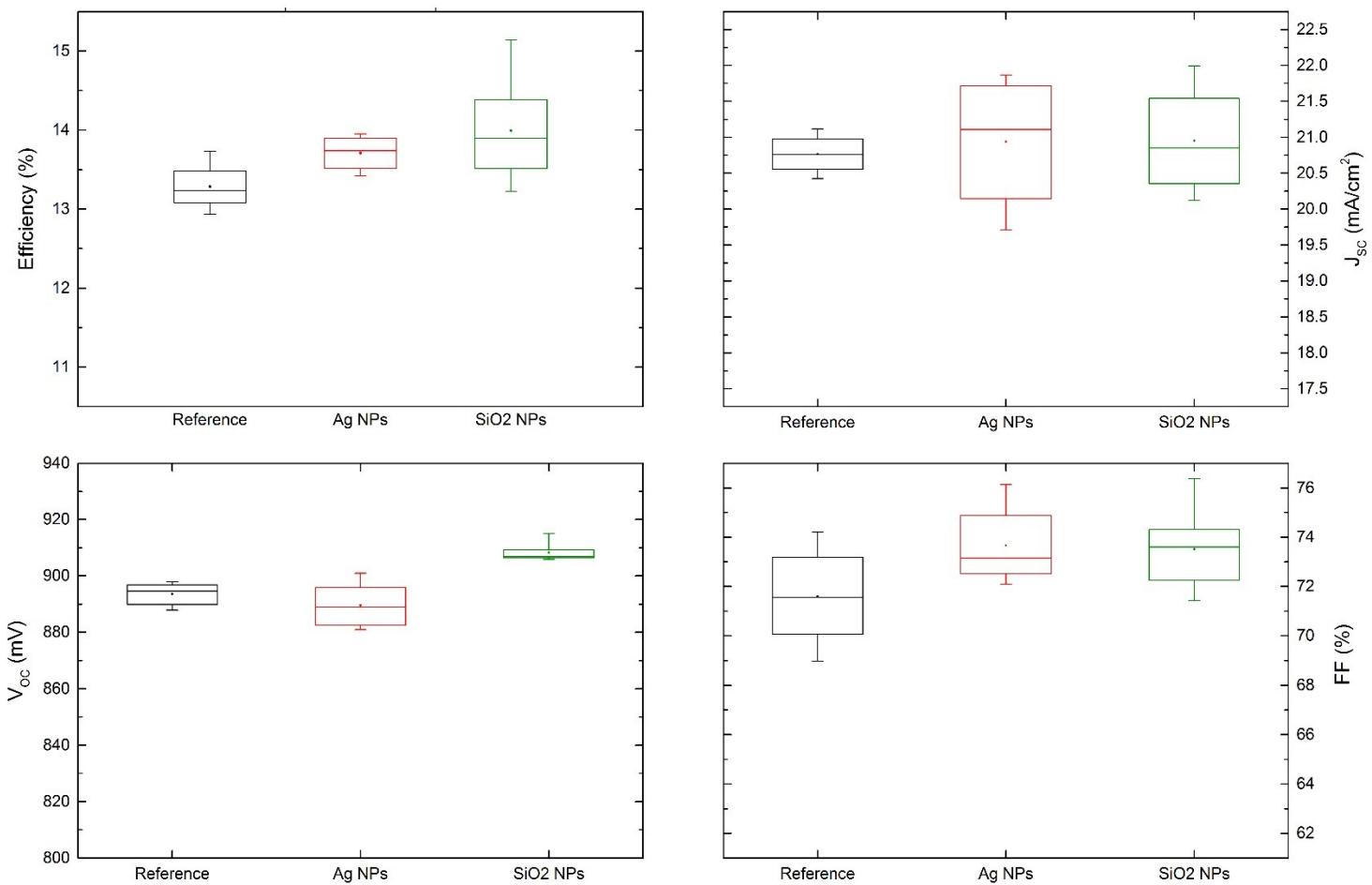


Figure S1: Box plots showing the distribution of results for device performance characteristics. The lower and upper hinge of the box represent the 25th and 75th percentiles respectively in the distribution of results. The mean result for each device category is represented by a circular dot within the box. Whiskers above and below the box indicate the maximum and minimum data points.

Table S1: The crystallite size, microstrain and dislocation density of perovskite films (from reference, Ag NPs and SiO₂ NPs devices) obtained from XRD spectral fitting.

Device	hkl	Mid Point (2θ)	β (deg)	Normalised Peak Intensity	Crystallite size, d_{hkl} (nm)	Microstrain, E (x 10⁻³)	Dislocation Density, d (x 10¹¹)
Reference	110	14.0	0.226	1827	37.1	8.00	0.794
	220	28.4	0.191	906	44.9	3.29	0.542
	310	31.8	0.202	515	42.6	3.10	0.600
Ag NPs	110	14.0	0.239	1633	35.1	8.46	0.887
	220	28.4	0.193	744	44.4	3.33	0.553
	310	31.8	0.191	512	45.2	2.92	0.535
SiO ₂ NPs	110	14.0	0.233	1850	35.9	8.27	0.848
	220	28.4	0.195	909	43.8	3.37	0.568
	310	31.8	0.214	559	40.4	3.27	0.670